OP508F, OP509 Series



Features:

- Flat lensed for wide acceptance angle (OP508F)
- Lensed for high sensitivity (OP509)
- Easily stackable on 0.100" (2.54 mm) hole centers
- Inexpensive plastic package
- Mechanically and spectrally matched to OP168 and OP268 series of infrared emitting diodes



Description:

Each device in the **OP508F** series consists of a NPN silicon phototransistor mounted in a flat, black plastic "end-looking" package. The flat sensing surface allows an acceptance half-angle of 60° when measured from the optical axis to the half power point.

Each device in the **OP509** series consists of a NPN silicon phototransistor mounted in a lensed, clear plastic "end-looking" package. The lensing effect of the package allows an acceptance half-angle of 25° when measured from the optical axis to the half power point.

OP508F and **OP509** series devices can be mounted on 0.100" (2.54 mm) hole centers, which makes them an ideal low-cost alternate to hermetic OP600 sensors. **OP508F** and **OP509** series devices are mechanically and spectrally matched to the OP168F and OP268F series of infrared emitting diodes.

Please refer to Application Bulletins 208 and 210 for additional design information and reliability (degradation) data.

For custom versions of the OP508F, OP509 and OP538F series devices please contact your OPTEK representative.

Applications:

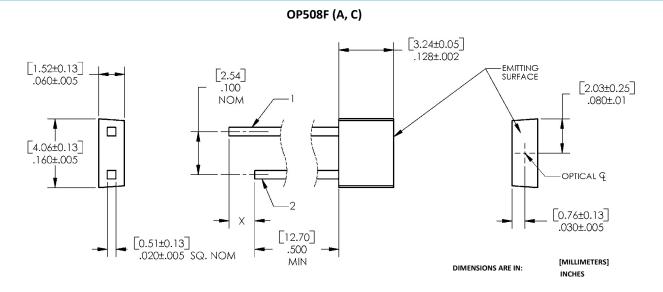
- Applications requiring a wide acceptance angle
- · Applications requiring high sensitivity
- Space-limited applications

| Ordering Information | | | | | | |
|----------------------|-----------------|------------------|----------------|--|--|--|
| Part Number | Sensor | Viewing Angle | Lead Length | | | |
| OP508FA | | 120° | | | | |
| OP508FC | | 120 | | | | |
| OP509A | Phototransistor | | 0.50" | | | |
| OP509B | | 50° | | | | |
| OP509C | | | | | | |

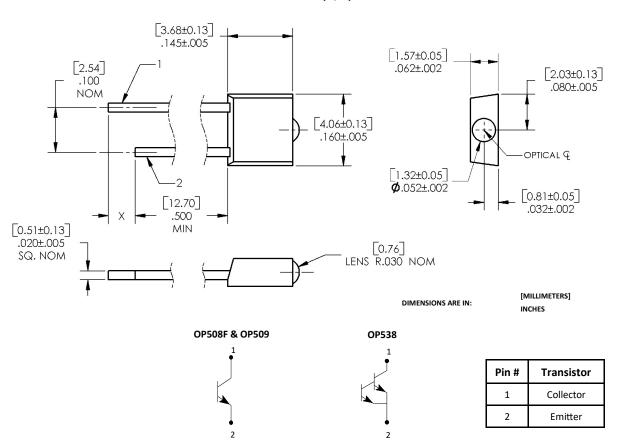


OP508F, OP509 Series





OP509 (A, B)



OP508F, OP509 Series



Electrical Specifications

| Absolute Maximum Ratings (T _A = 25° C unless otherwise noted) | | | | |
|---|-----------------------|--|--|--|
| Storage and Operating Temperature Range | -40° C to +100° C | | | |
| Collector-Emitter Voltage | 30 V | | | |
| Emitter-Collector Voltage | 5 V | | | |
| Lead Soldering Temperature [1/16 inch (1.6 mm) from case for 5 seconds with soldering iron] | 260° C ⁽¹⁾ | | | |
| Power Dissipation | 100 mW ⁽²⁾ | | | |

| SYMBOL | PARAMETER | MIN | TYP | MAX | UNITS | TEST CONDITIONS |
|----------------------|--|------------------------------|-------------|--------------------------|-------|---|
| I _{C(ON)} | On-State Collector Current OP509A (Dome Lens) OP508FA (Flat Lens) OP509B (Dome Lens) OP508FC (Flat Lens) | 5.70 2.70 1.40 0.34 | - - - | 20.00 - 10.60 - | mA | $V_{CE} = 5.0 \text{ V}, E_E = 5 \text{ mW/cm}^{2(3)}$ |
| I _C /Δ T | Relative I _C Charge with Temperature | - | 1.00 | - | %/°C | V _{CE} = 5 V.0, E _E = 1.0 mW/cm ²⁽³⁾ , λ = 890 nm |
| I _{CEO} | Collector-Dark Current OP508F & OP509 OP538F | | - - | 100 225 | nA | $V_{CE} = 10.0 \text{ V}, E_E = 0^{(4)}$ |
| V _{(BR)CEO} | Collector-Emitter Breakdown Voltage OP508F & OP509 | 30 | - | - | V | I _C = 1.00 mA, E _E = 0 |
| V _{(BR)ECO} | Emitter-Collector Breakdown Voltage | 5 | - | - | ٧ | Ι _Ε = 100 μΑ |
| V _{CE(SAT)} | Collector-Emitter Saturation Voltage OP508F OP509 | - | - | 0.4 | V | I_C = 300 μA, E_E = 5 mW/cm ^{2 (3)} I_C = 250 μA, E_E = 5 mW/cm ^{2 (3)} |

Notes:

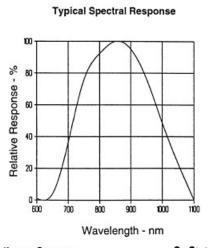
- 1. RMA flux is recommended. Duration can be extended to 10 seconds maximum when flow soldering. A maximum 20 grams force may be applied to the leads when soldering.
- 2. Derate linearly 1.33 mW/° C above 25° C.
- 3. Light source is an unfiltered GaAs or GaAlAs LED with a peak emission wavelength of 935 or 890 nm and a radiometric intensity level which varies less than 10% over the entire lens surface of the phototransistor being tested.
- 4. To calculate typical collector dark current in μA , use the formula $I_{CEO} = 10^{(0.040 \, \text{T}_A 3.4)}$, where T_A is ambient temperature in °C.

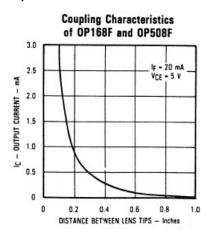
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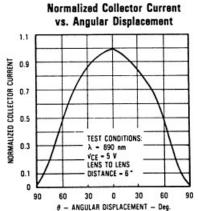


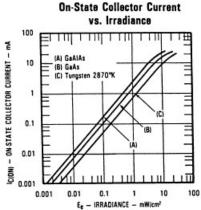
Performance

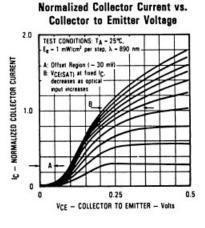
OP508FA, OP508FC, OP508FD

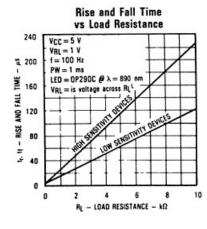


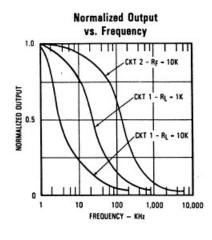


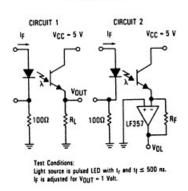












Switching Time

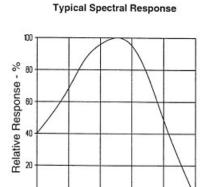
Test Circuit

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Performance

OP509A, OP509B, OP509D

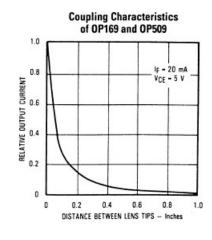


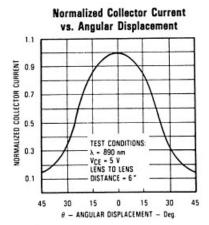
am

Wavelength - nm

1000

1100





6m

700

